Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/816,855	OKANO, AKIHIRO	
Examiner	Art Unit	
Aaron M. Richer	2628	

	SEARCHED				
Class	Subclass	Date	Examiner		
345	617	6/7/2006	AMR		
Above	Updated	9/7/2006	AMR		
348	173	9/7/2006	AMR		
Above	Updated	2/27/2007	AMR		
			8		

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
-:					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Updated previous examiner's seach - EAST (USPGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB) - see search history printout	6/7/2006	AMR			
Updated	9/7/2006	AMR			
Updated	2/27/2007	AMR			
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